

Search Notes

Application/Control No.

10/668,643

Examiner

Mark K. Han

Applicant(s)/Patent under
Reexamination

TROCKI ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	93.01	3/20/2006	mbh
	118		
	154		
	131		
	152		
	181		
	187		
	533		
	534		
	535		
600	431		
	432		
128	dig.1		
	dig.12		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search	3/20/2006	mbh
Inventor name search	3/20/2006	mbh